



Substitute Form PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
09752-095001Application No.
09/912,795Information Disclosure Statement
by Applicant

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Jason F. HunzingerFiling Date
July 24, 2001Group Art Unit
2:81 2686

U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
JC	AA	5,504,939	04/02/1996	Mayrand et al.	455	120	
AC	AB	5,903,840	05/11/1999	Bertacchi	455	436	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
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	AK						

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Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

JF Hunzinger

Date Considered

6/20/01

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Substitute Disclosure Form (PTO-1449)

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FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET NO.

4041L-000092

SERIAL NO.

09/912,795

APPLICANT

Jason F. Hunzinger

FILING DATE

07/24/2001

GROUP

2686

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		5,590,177	12/1996	Vilmur, et al.		

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.		JP 2000-83010	03/2000	Japan		Abstract	
2.		JP 2000-125334	04/2000	Japan		Abstract	
3.		JP 8-126048	05/1996	Japan		Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		Japanese Office Action dated February 3, 2004 from similar Japanese patent.

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